	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L1	58	(electron$1 adj10 beams) and (conver$7 adj30 lens$3) and (coat$5 adj30 lens$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 18:49
2	BRS	L2	17	(electron$1 adj10 beams) and (conver$7 adj30 lens$3) and (coat$5 adj30 lens$3) and ((inspect$5 or test$5) adj10 (sample$1 or wafer$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 19:49
3	BRS	L3	1	(electron$1 adj10 beams) and (deflect$5 adj30 ferromagnetic adj30 magnet$1) and ((inspect$5 or test$5) adj10 (sample$1 or wafer$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 19:50
4	BRS	L4	20	(electron$1 adj10 beams) and (separat$5 adj30 electrostatic adj30 electromagnetic) and ((inspect$5 or test$5) adj10 (sample$1 or wafer$1))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 19:51

	Type	L #	Hits	Search Text	DBs	Time Stamp
5	BRS	L5	0	((electron$1 adj10 beams) and (conver$7 adj30 lens$3) and (coat$5 adj30 lens$3) and ((inspect$5 or test$5) adj10 (sample$1 or wafer$1))).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 19:49
6	BRS	L6	0	((electron$1 adj10 beams) and (deflect$5 adj30 ferromagnetic adj30 magnet$1) and ((inspect$5 or test$5) adj10 (sample$1 or wafer$1))).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 19:50
7	BRS	L7	2	((electron$1 adj10 beams) and (separat$5 adj30 electrostatic adj30 electromagnetic) and ((inspect$5 or test$5) adj10 (sample$1 or wafer$1))).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2006/10/15 19:51